#### TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

# 2SC3605

#### VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

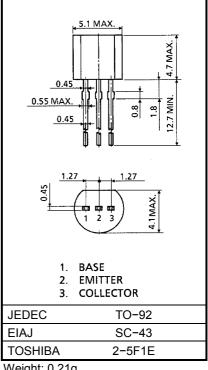
#### Unit in mm

#### **FEATURES:**

- Low Noise Figure, High Gain
- NF = 1.1dB,  $|S_{21e}|^2 = 10dB$  (f = 1GHz)

### **MAXIMUM RATINGS (Ta = 25°C)**

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CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	$V_{CBO}$	20	V
Collector-Emitter Voltage	V <sub>CEO</sub>	12	V
Emitter-Base Voltage	V <sub>EBO</sub>	3	V
Collector Current	Ic	80	mA
Base Current	Ι <sub>Β</sub>	40	mA
Collector Power Dissipation	PC	600	mW
Junction Temperature	Tj	150	°C
Storage Temperature Range	T <sub>stg</sub>	-55~150	°C



Weight: 0.21g

## MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Transition Frequency	f <sub>T</sub>	V <sub>CE</sub> = 10V, I <sub>C</sub> = 20mA	5	6.5	_	GHz
Insertion Gain	S <sub>21e</sub>   <sup>2</sup> (1)	V <sub>CE</sub> = 10V, I <sub>C</sub> = 20mA, f = 500MHz	_	16		- dB
	S <sub>21e</sub>   <sup>2</sup> (2)	V <sub>CE</sub> = 10V, I <sub>C</sub> = 20mA, f = 1GHz	7.5	10	_	
Noise Figure	NF (1)	V <sub>CE</sub> = 10V, I <sub>C</sub> = 5mA, f = 1GHz	_	1.1	-	dB
	NF (2)	V <sub>CE</sub> = 10V, I <sub>C</sub> = 40mA, f = 1GHz	_	1.8	3	ub

damage to property.

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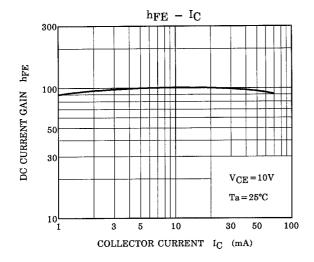
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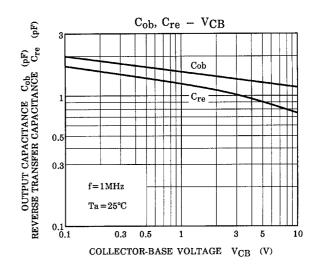


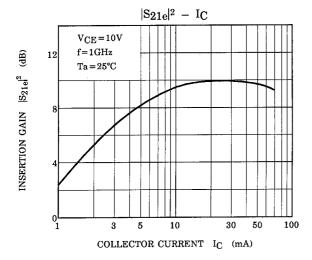
# ELECTRICAL CHARACTERISTICS (Ta=25°C)

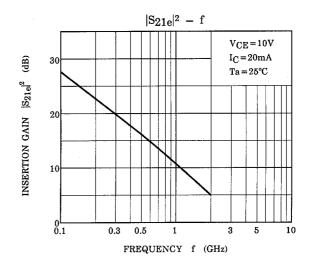
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Collector Cut-off Current	I <sub>CBO</sub>	V <sub>CE</sub> = 10V, I <sub>E</sub> = 0	_	_	1	μΑ
Emitter Cut-off Current	I <sub>EBO</sub>	V <sub>EB</sub> = 1V, I <sub>E</sub> = 0	1	_	1	μΑ
DC Current Gain	h <sub>FE</sub>	V <sub>CE</sub> = 10V, I <sub>C</sub> = 20mA	30	_	250	_
Output Capacitance	C <sub>ob</sub>	V <sub>CB</sub> = 10V, I <sub>E</sub> = 0, f = 1MHz	_	1.2	_	pF
Reverse Transfer Capacitance	C <sub>re</sub>	(Note)	_	0.75	1.2	pF

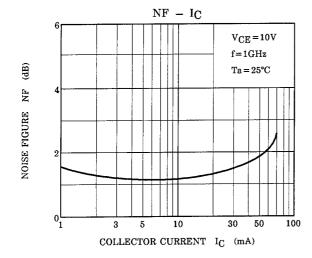
Note:  $C_{\text{re}}$  is measured by 3-terminal method with Capacitance Bridge.

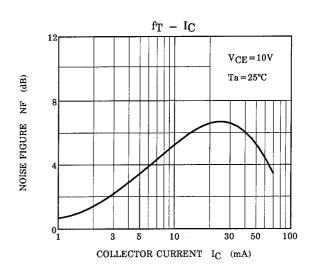


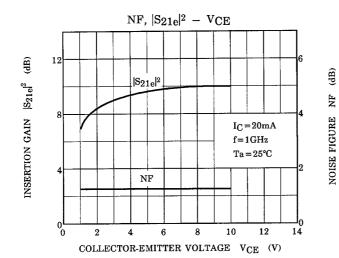


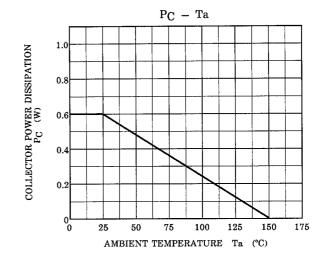






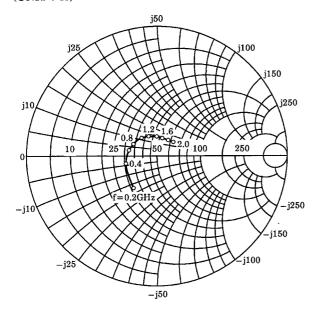


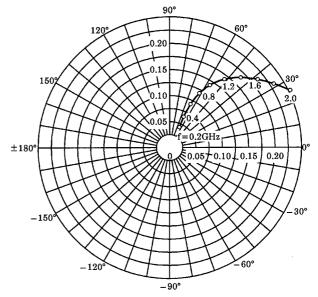




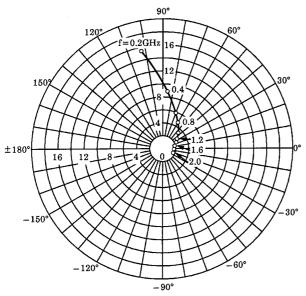
 $\begin{array}{l} S_{11e} \\ V_{CE}\!=\!10V \\ I_{C}\!=\!20\text{mA} \\ Ta\!=\!25^{\circ}\!C \\ (UNIT:\Omega) \end{array}$ 

 $\begin{array}{c} S_{12e} \\ V_{CE} = 10V \\ I_{C} = 20 \text{mA} \\ Ta = 25^{\circ}C \end{array}$ 





 $\begin{array}{c} \mathrm{S}_{21e} \\ \mathrm{V}_{CE} \!=\! 10\mathrm{V} \\ \mathrm{I}_{C} \!=\! 20\mathrm{mA} \\ \mathrm{Ta} \!=\! 25^{\circ}\!\mathrm{C} \end{array}$ 



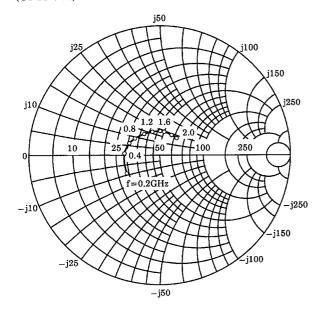
 $\begin{array}{c} S_{22e} \\ V_{CE} = 10V \\ I_{C} = 20mA \\ T_{a} = 25^{\circ}C \\ (UNIT:\Omega) \\ \\ j_{25} \\ \\ -j_{10} \\ \\ -j_{25} \\ \end{array}$ 

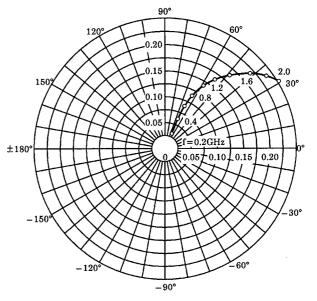
\_j50

 $S_{11e}$   $V_{CE}=10V$   $I_{C}=40\text{mA}$   $T_{a}=25^{\circ}\text{C}$  $(U\text{NIT}:\Omega)$ 



 $S_{22e}$ 





 $\begin{array}{l} \mathrm{S}_{21e} \\ \mathrm{V}_{\mathrm{CE}} \! = \! 10\mathrm{V} \\ \mathrm{I}_{\mathrm{C}} \! = \! 40\mathrm{mA} \\ \mathrm{Ta} \! = \! 25^{\circ}\mathrm{C} \end{array}$ 

